

<b>Notice of References Cited</b>	Application/Control No. 10/830,021		Applicant(s)/Patent Under Reexamination FUNATO ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,716,286	02-1973	St. John et al.	359/3
*	B	US-5,016,953	05-1991	Moss et al.	359/9
*	C	US-4,998,787	03-1991	Caputi et al.	359/20
*	D	US-3,885,545	05-1975	Charron et al.	123/179.15
*	E	US-5,056,039	10-1991	Caulfield, H. John	706/40
*	F	US-2006/0055993	03-2006	Kobayashi et al.	359/003
*	G	US-4,224,480	09-1980	Satoh et al.	369/47.48
*	H	US-5,576,853	11-1996	Molteni et al.	359/12
*	I	US-2002/0003637	01-2002	Watanabe, Masachika	359/22
*	J	US-2004/0174579	09-2004	Sekine et al.	359/025
*	K	US-6,730,442	05-2004	Sutherland et al.	430/1
*	L	US-5,455,691	10-1995	Kuwayama et al.	359/10
*	M	US-4,720,158	01-1988	Kuwayama et al.	359/12

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 60035701 A	02-1985	Japan	KUWAYAMA, TETSUO	***
	O	JP 60122982 A	07-1985	Japan	KUWAYAMA et al.	***
	P	JP 01252988 A	10-1989	Japan	KATO et al.	**
	Q	JP 09138632 A	05-1997	Japan	TODA, TOSHITAKA	***
	R	JP 02257183 A	10-1990	Japan	MIFUNE, HIROYASU	***
	S	JP 60238885 A	11-1985	Japan	KATO et al.	***
	T	JP 62036684 A	02-1987	Japan	KATO et al.	***

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Dickson et al., IBM Technical disclosure bulletin Vol. 24(4) pp. 1896-1897 (09/1981)
	V	Vanin, "holographic copying (review)" Sov. J. Quantum. Electron., Vol. 8(7) pp. 809-818 (07/1978)
	W	Vanin, Preparation of reflection holograms by interference copying of transmission holograms", Sov. J. Quantum. Electron., Vol. 8(7) pp. 855-859 (07/1978)
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,983,017	01-1991	Tsuji et al.	359/566
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 10133555 A	05-1998	Japan	ONO et al.	**
	O	JP 55045041 A	03-1980	Japan	KATO, MAKOTO	**
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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